

**Notice of References Cited**

Application/Control No.

10/036,107

Applicant(s)/Patent Under  
Reexamination  
FAST ET AL.

Examiner

Chanda L. Harris

Art Unit

3714

Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2002/0059376 A1	05-2002	Schwartz	709/204
	B	US-2002/0182570 A1	12-2002	Croteau et al.	434/107
	C	US-2003/0008270 A1	01-2003	Fleishman	434/322
	D	US-2002/0127525 A1	09-2002	Arington et al.	434/262
	E	US-2002/0014400 A1	01-2003	Siegel	707/3
	F	US-2002/0072040 A1	06-2002	Bajer et al.	434/236
	G	US-6074213	06-2000	Hon	434/262x
	H	US-5676551	10-1997	Knight et al.	434/236x
	I	US-6105046	08-2000	Greenfield et al.	707/530x
	J	US-6408263 B1	06-2002	Summers	703/6x
	K	US-2003/0031986 A1	02-2003	Siddle	434/11
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.